## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of: TI-37087

Rishi Bhooshan, et al. Art Unit: 2825

Serial No: 10/710,693 Examiner: Phallaka Kik

Filed: July 29, 2004 Conf. No.: 4692

For: Electro-Migration (EM) and Voltage (IR) Drop Analysis of Integrated Circuit (IC)

Designs

## **AMENDMENT PURSUANT TO 37 CFR 1.111**

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

Dear Sir:

Applicant has received the Office Action mailed January 19, 2007, which rejected Claims 1-12 and 25-36. Please amend the above-identified patent application as follows: